

General Description

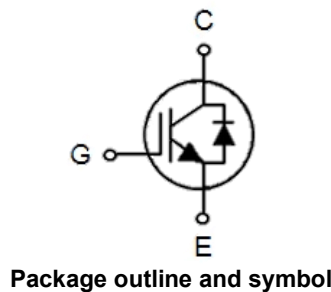
This IGBT is produced using advanced Magnachip's Field Stop Trench IGBT Technology, which provides low $V_{CE(sat)}$, high speed switching and high ruggedness performance and excellent quality.

Applications

- E-compressor
- PTC Heater

Features

- High Speed Switching & Low Power Loss
- $V_{CE(sat)} = 1.60V$ @ $I_C = 40A$
- High Input Impedance
- $t_{SC} = 10\mu s$
- Ultra-soft, fast recovery anti-parallel diode
- Ultra-narrowed V_F distribution control
- Positive Temperature Coefficient for easy paralleling
- AEC-Q101 qualified



- G : Gate
- C : Collector
- E : Emitter

Absolute Maximum Ratings

Characteristics		Symbol	Rating	Unit
Collector-emitter voltage		V_{CES}	1200	V
Gate-emitter voltage		V_{GE}	± 25	V
DC collector current, limited by T_{vjmax}	$T_C = 25^\circ C$	I_C	80	A
	$T_C = 100^\circ C$		40	A
Pulsed collector current, t_p limited by T_{vjmax}		I_{Cpuls}	160	A
Diode forward current, limited by T_{vjmax}	$T_C = 25^\circ C$	I_F	80	A
	$T_C = 100^\circ C$		40	A
Diode pulsed current, Pulse time limited by T_{vjmax}		I_{Fpuls}	160	A
Power dissipation	$T_C = 25^\circ C$	P_D	484	W
	$T_C = 100^\circ C$		242	W
Short circuit withstand time $V_{CE} = 600V$, $V_{GE} = 15V$, $T_C = 150^\circ C$		t_{SC}	10	μs
Operating Junction temperature range		T_{vj}	-40~175	$^\circ C$
Storage temperature range		T_{stg}	-55~150	$^\circ C$

Thermal Characteristics

Characteristics	Symbol	Rating	Unit
Thermal resistance junction-to-ambient	$R_{th(j-a)}$	40	$^\circ C/W$
Thermal resistance junction-to-case for IGBT	$R_{th(j-c)}$	0.31	
Thermal resistance junction-to-case for Diode	$R_{th(j-c)}$	0.60	

Ordering Information

Part Number	Marking	Temp. Range	Package	Packing	RoHS Status
AMBQ40T120RFRA	40T120RFRA	-55~150°C	TO-247	Tube	Compliant

Electrical Characteristics ($T_{vj} = 25^\circ\text{C}$ unless otherwise specified)

Characteristics	Symbol	Conditions		Min	Typ	Max	Unit
Static Characteristics							
Collector-emitter breakdown voltage	BV_{CES}	$I_C = 1\text{mA}$, $V_{GE} = 0\text{V}$		1200	-	-	V
Collector-emitter saturation voltage	$V_{CE(\text{sat})}$	$I_C = 40\text{A}$, $V_{GE} = 15\text{V}$	$T_{vj} = 25^\circ\text{C}$	-	1.60	2.1	V
			$T_{vj} = 175^\circ\text{C}$	-	2.10	-	
Diode forward voltage	V_F	$V_{GE} = 0\text{V}$, $I_F = 40\text{A}$	$T_{vj} = 25^\circ\text{C}$	-	2.00	2.5	V
			$T_{vj} = 175^\circ\text{C}$	-	2.10	-	
Gate-emitter threshold voltage	$V_{GE(\text{th})}$	$V_{CE} = V_{GE}$, $I_C = 1\text{mA}$		5.0	6.0	7.0	V
Zero gate voltage collector current	I_{CES}	$V_{CE} = 1200\text{V}$, $V_{GE} = 0\text{V}$		-	-	1	mA
Gate-emitter leakage current	I_{GES}	$V_{GE} = 25\text{V}$, $V_{CE} = 0\text{V}$		-	-	±250	nA

Dynamic Characteristics

Total gate charge	Q_G	$V_{CE} = 960\text{V}$, $I_C = 40\text{A}$, $V_{GE} = 15\text{V}$	-	151.8	-	nC
Gate-emitter charge	Q_{GE}		-	39.0	-	
Gate-collector charge	Q_{GC}		-	70.7	-	
Input capacitance	C_{ies}	$V_{CE} = 30\text{V}$, $V_{GE} = 0\text{V}$, $f = 800\text{kHz}$	-	4110	-	pF
Output capacitance	C_{oes}		-	163	-	
Reverse transfer capacitance	C_{res}		-	29	-	

Switching Characteristics

Turn-on delay time	$t_{d(on)}$	$V_{GE} = 0/15\text{V}$, $V_{CC} = 600\text{V}$, $I_C = 40\text{A}$, $R_G = 10\Omega$, Inductive Load, $T_{vj} = 25^\circ\text{C}$	-	63.0	-	ns
Rise time	t_r		-	61.7	-	
Turn-off delay time	$t_{d(off)}$		-	169.7	-	
Fall time	t_f		-	171.0	-	
Turn-on switching energy	E_{on}	$V_{GE} = 0/15\text{V}$, $V_{CC} = 600\text{V}$, $I_C = 40\text{A}$, $R_G = 10\Omega$, Inductive Load, $T_{vj} = 175^\circ\text{C}$	-	3.2	-	mJ
Turn-off switching energy	E_{off}		-	1.9	-	
Total switching energy	E_{ts}		-	5.1	-	
Turn-on delay time	$t_{d(on)}$		-	57.0	-	ns
Rise time	t_r		-	74.3	-	
Turn-off delay time	$t_{d(off)}$		-	184.7	-	
Fall time	t_f		-	211.3	-	
Turn-on switching energy	E_{on}	$I_F = 40\text{A}$, $di_F/dt = 400\text{A}/\mu\text{s}$, $T_{vj} = 25^\circ\text{C}$	-	5.1	-	mJ
Turn-off switching energy	E_{off}		-	2.3	-	
Total switching energy	E_{ts}		-	7.4	-	
Reverse recovery time	t_{rr}		-	174.0	-	ns
Reverse recovery current	I_{rr}	$I_F = 40\text{A}$, $di_F/dt = 400\text{A}/\mu\text{s}$, $T_{vj} = 175^\circ\text{C}$	-	13.0	-	
Reverse recovery charge	Q_{rr}		-	1.2	-	
Reverse recovery time	t_{rr}		-	341.0	-	
Reverse recovery current	I_{rr}	$I_F = 40\text{A}$, $di_F/dt = 400\text{A}/\mu\text{s}$, $T_{vj} = 175^\circ\text{C}$	-	19.0	-	A
Reverse recovery charge	Q_{rr}		-	3.8	-	

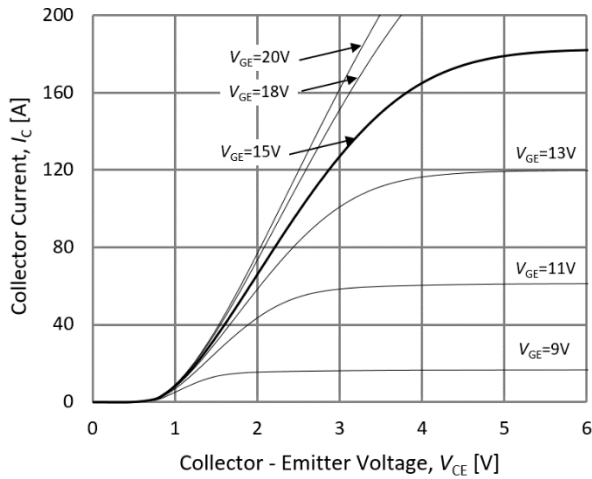


Fig.1. Typical output characteristics($T_{vj}=25^{\circ}\text{C}$)

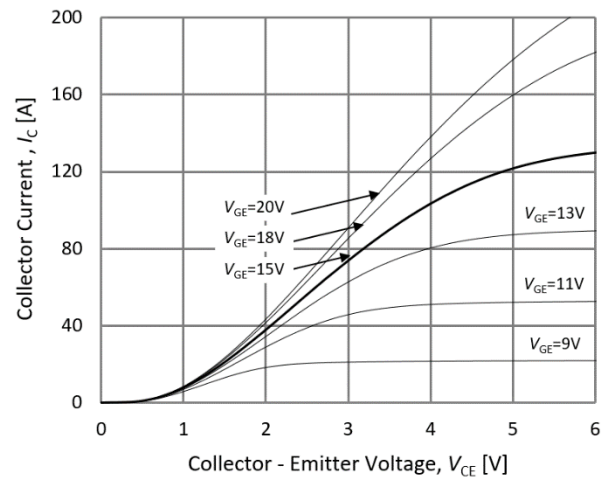


Fig.2. Typical output characteristics($T_{vj}=175^{\circ}\text{C}$)

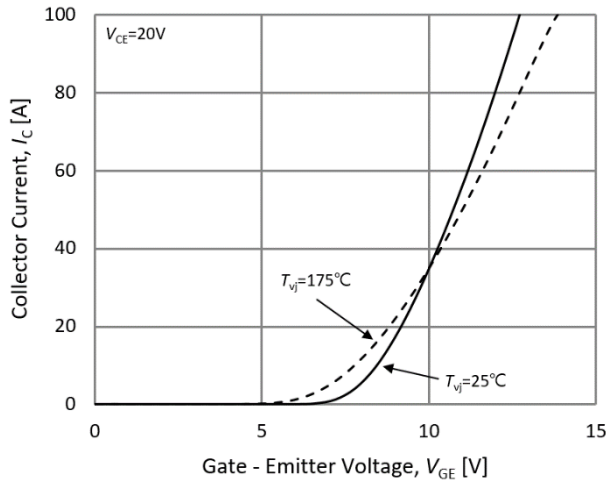


Fig.3. Typical transfer characteristics

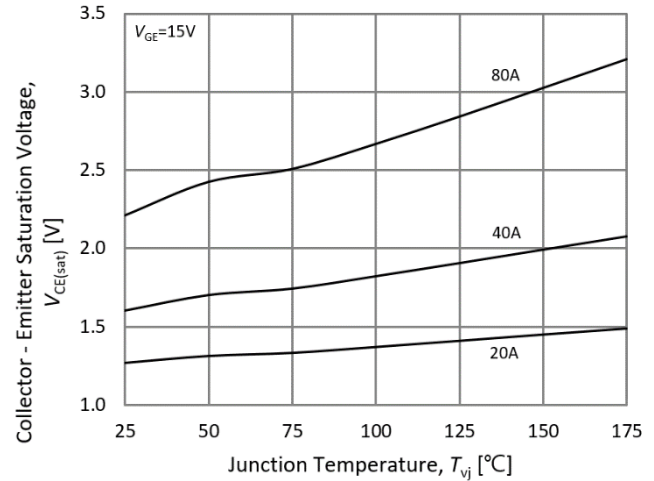


Fig.4. Typical collector emitter saturation voltage-junction temperature

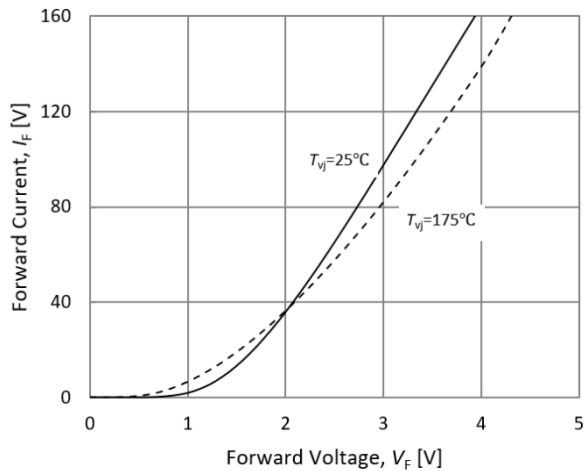


Fig.5. Diode Forward Characteristics

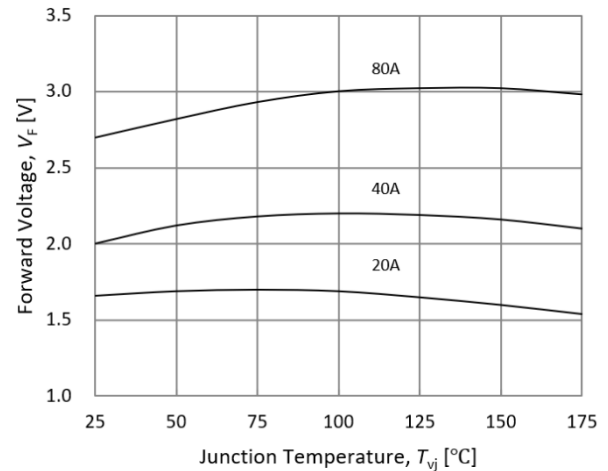
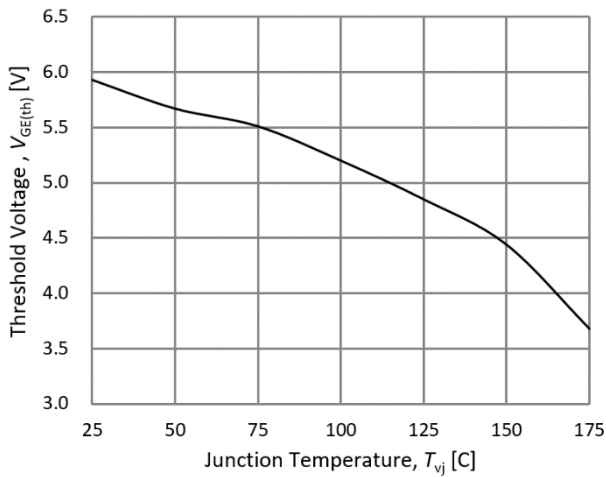
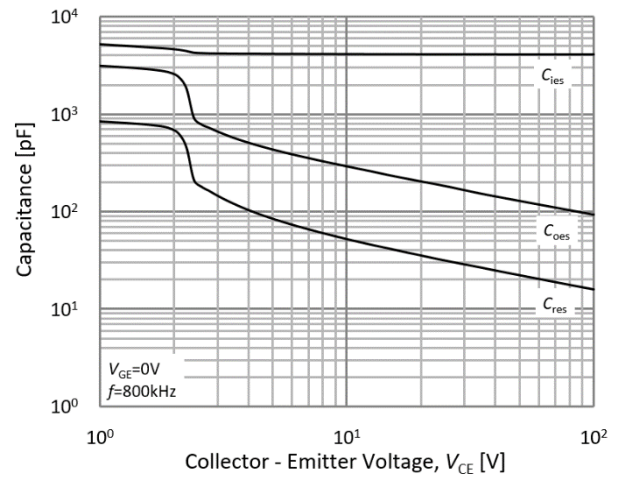
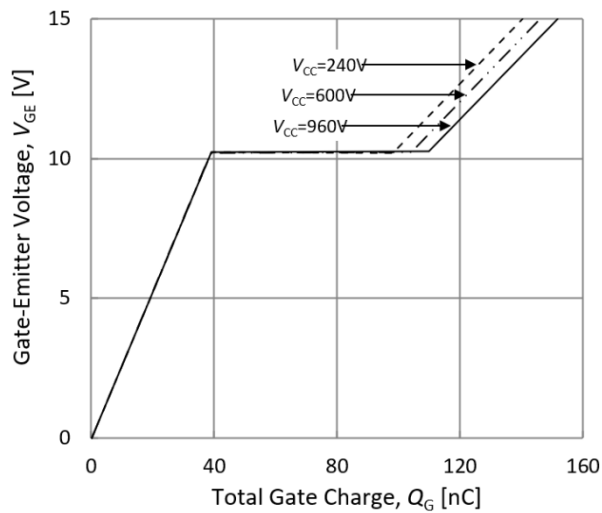
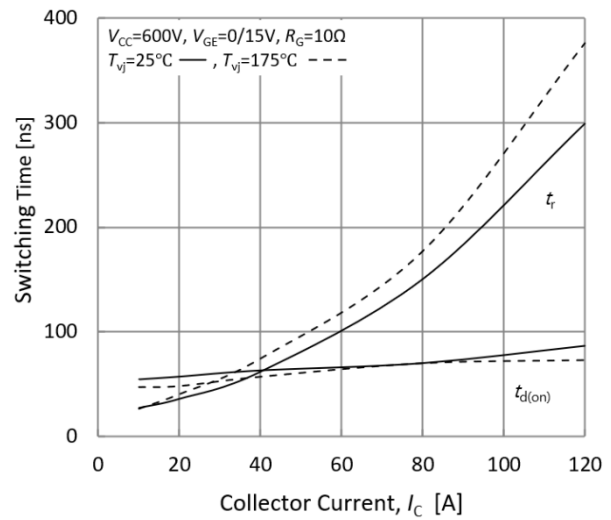
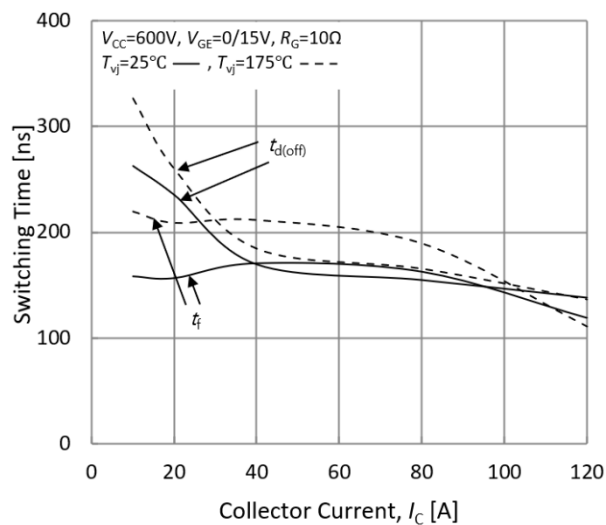
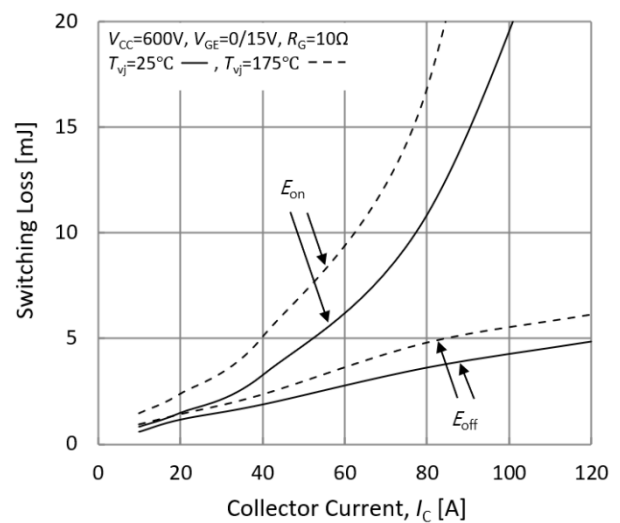
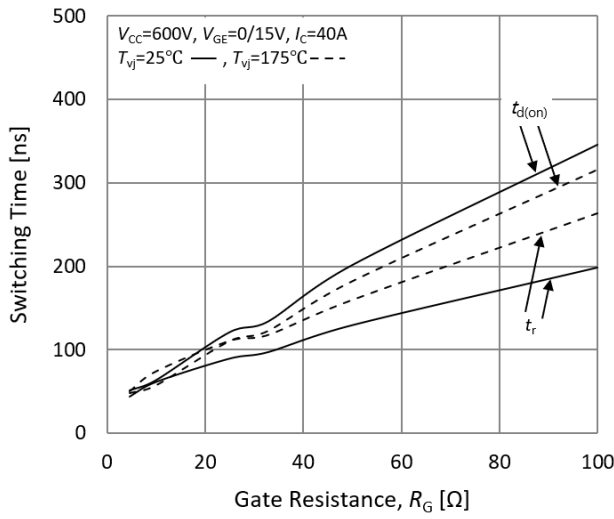
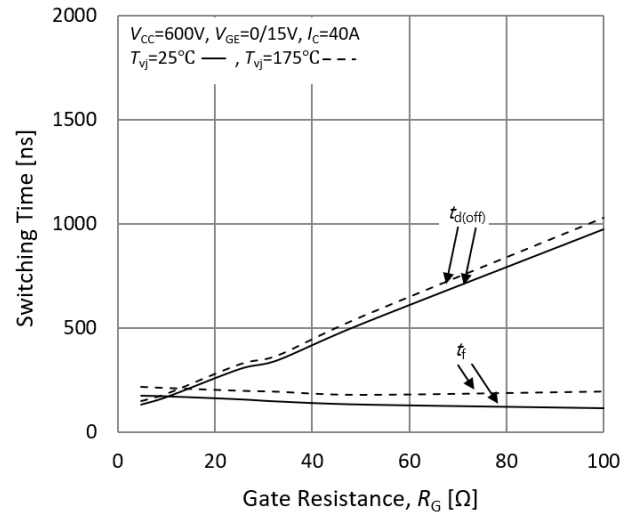
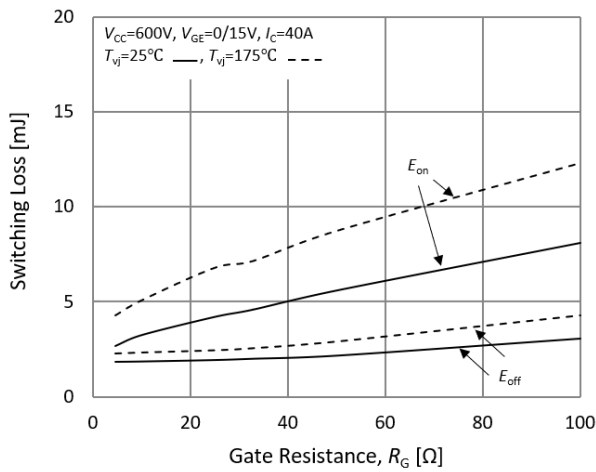
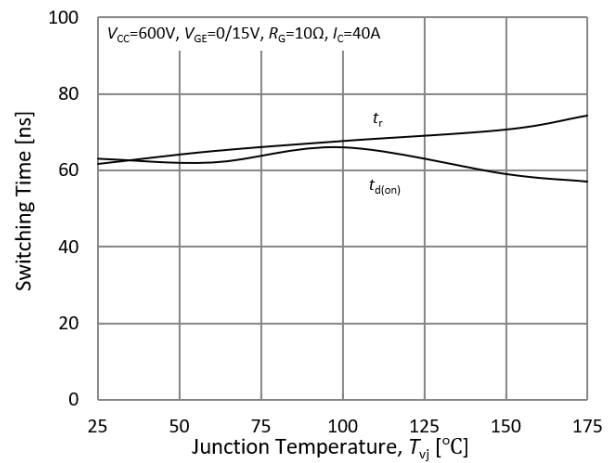
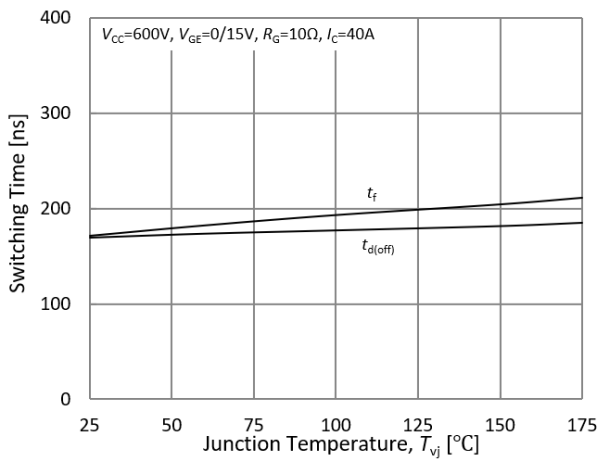
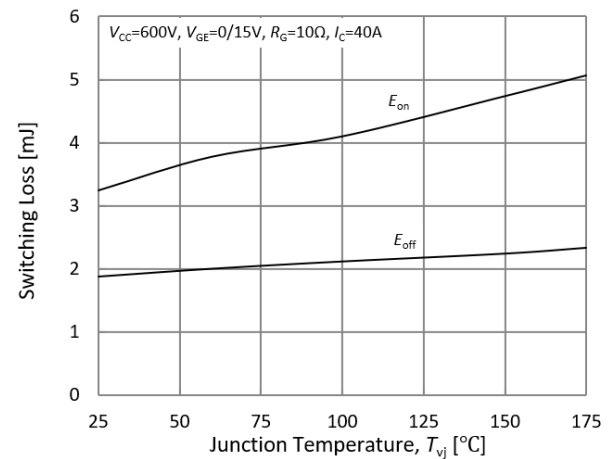
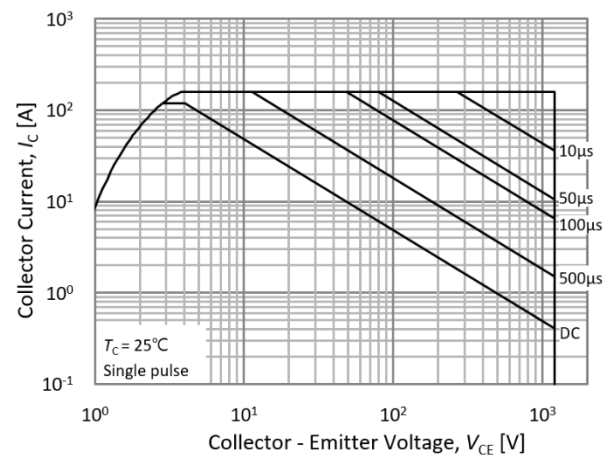
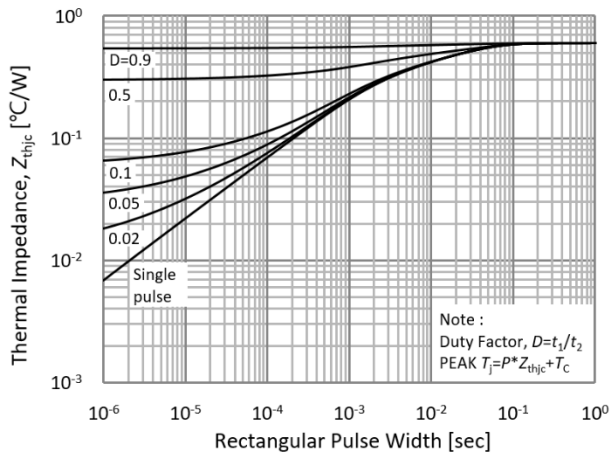
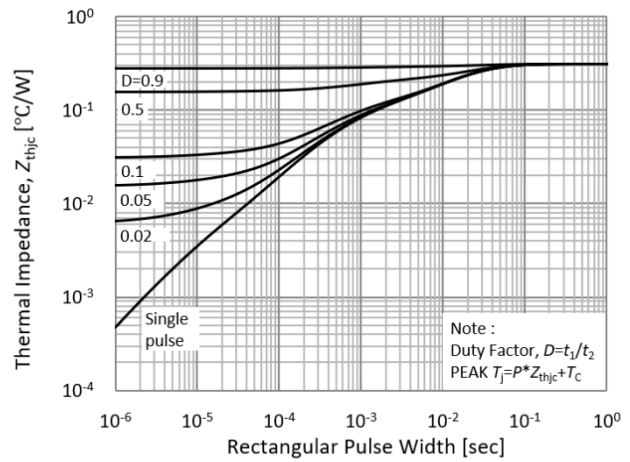
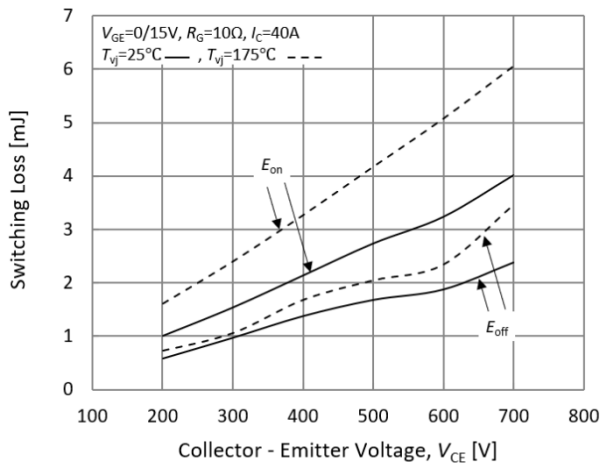
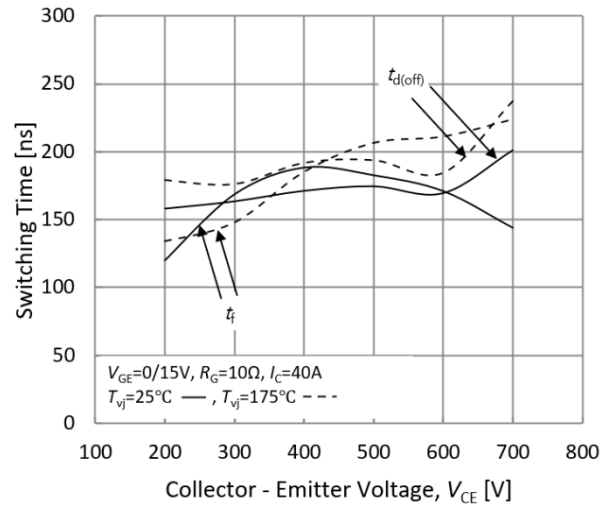
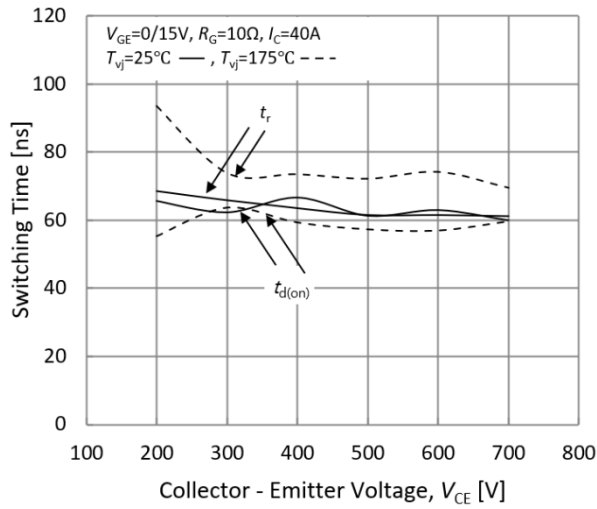


Fig.6. Diode Forward-Junction Temperature


Fig.7. Threshold voltage-junction temperature

Fig.8. Typical capacitance

Fig.9. Typical gate charge

Fig.10. Typical turn on times-collector current

Fig.11. Typical turn off times-collector current

Fig.12. Switching losses-collector current


Fig.13. Typical turn on times-gate resistance

Fig.14. Typical turn off times-gate resistance

Fig.15. Switching losses-gate resistance

Fig.16. Typical turn on times-junction temperature

Fig.17. Typical turn off times-junction temperature

Fig.18. Switching losses-junction temperature



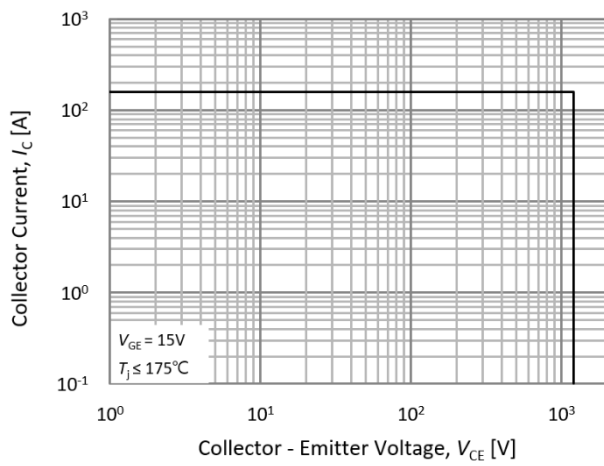
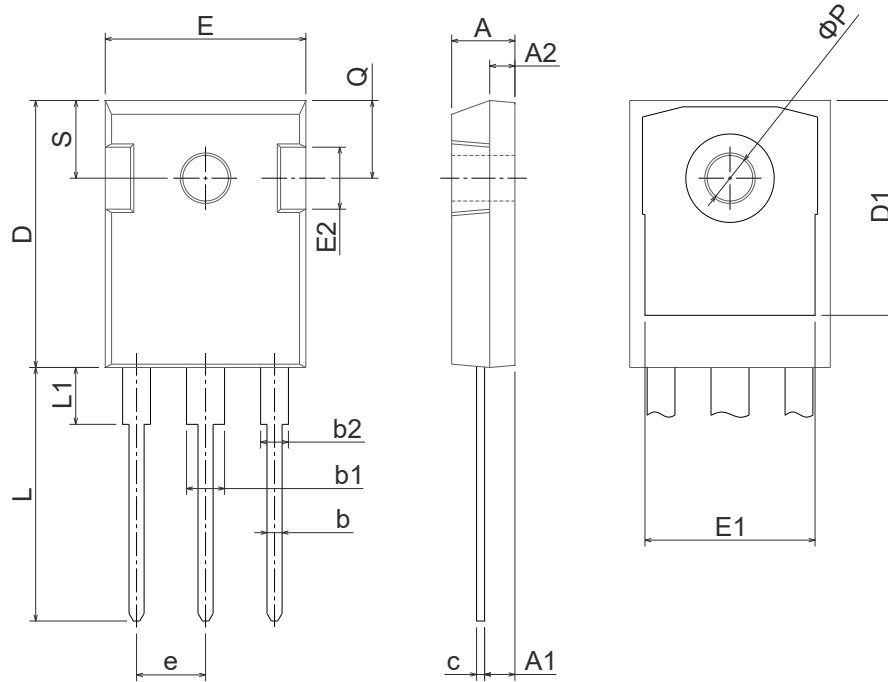


Fig.25. RBSOA

Physical Dimension

TO-247

Dimensions are in millimeters, unless otherwise specified



Dimension	Min(mm)	Max(mm)
A	4.70	5.31
A1	2.20	2.60
A2	1.50	2.49
b	0.99	1.40
b1	2.59	3.43
b2	1.65	2.39
c	0.38	0.89
D	20.30	21.46
D1	13.08	-
E	15.45	16.26
E1	13.06	14.02
E2	4.32	5.49
e	5.45BSC	
L	19.81	20.57
L1	-	4.50
ΦP	3.50	3.70
Q	5.38	6.20
S	6.15BSC	

Note: Package body size, length and width do not include mold flash, protrusions and gate burrs.



DISCLAIMER:

The Products are not designed for use in hostile environments, including, without limitation, aircraft, nuclear power generation, medical appliances, and devices or systems in which malfunction of any Product can reasonably be expected to result in a personal injury. Seller's customers using or selling Seller's products for use in such applications do so at their own risk and agree to fully defend and indemnify Seller.

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